

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10599310	VOLOSHIN ET AL.
	Examiner	Art Unit
	Young J Kim	1637

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Patent Databases (USPT, USPPG, EPO, JPO, DERWENT, IBM-TDB) - see enclosed for text search strategy	9/29/2010	/YJK/
STN commercial Databases (Biosis, Medline, Embase, Embal, CAPlus) - see enclosed for text search strategy	9/29/2010	/YJK/
STN search updated - see enclosed	4/28/2011	/YJK/
Patent Databases - updated - see enclosed	4/28/2011	/YJK/
Patent Databases - updated	10/6/2011	/YJK/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	Interference Database search - see enclosed	10/6/2011	/YJK/

	/Young J Kim/ Primary Examiner. Art Unit 1637
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